

Search Notes

Application/Control No.

10/809,254

Examiner

Hai H. Huynh

Applicant(s)/Patent under
Reexamination

LIU ET AL.

Art Unit

3747

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 123 | 299 | 8/24/2005 | HHH |
| 123 | 300 | 8/24/2005 | HHH |
| 123 | 305 | 8/24/2005 | HHH |
| 123 | 431 | 8/24/2005 | HHH |
| 123 | 436 | 8/24/2005 | HHH |
| 123 | 698 | 8/24/2005 | HHH |
| 123 | 443 | 8/24/2005 | HHH |
| 701 | 103 | 8/24/2005 | HHH |
| 701 | 104 | 8/24/2005 | HHH |
| 701 | 105 | 8/24/2005 | HHH |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| East | 8/24/2005 | HHH |
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